

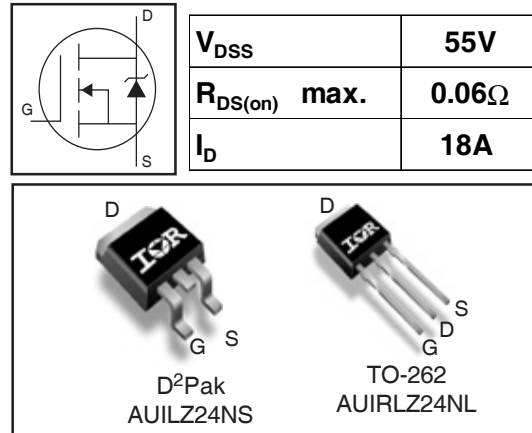
### Features

- Advanced Process Technology
- Logic Level Gate Drive
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to  $T_{jmax}$
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

### Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

### HEXFET® Power MOSFET



| Base Part Number | Package Type | Standard Pack      |          | Orderable Part Number |
|------------------|--------------|--------------------|----------|-----------------------|
|                  |              | Form               | Quantity |                       |
| AUIRLZ24NS       | D2-Pak       | Tube               | 50       | AUIRLZ24NS            |
|                  |              | Tape and Reel Left | 800      | AUIRLZ24NSTR          |
| AUIRLZ24NL       | TO-262       | Tube               | 50       | AUIRLZ24NL            |

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

|                                   | Parameter   | Max.         | Units |
|-----------------------------------|---|--------------|-------|
| $I_D$ @ $T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10V$ ⑤              | 18           | A     |
| $I_D$ @ $T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10V$ ⑤              | 13           |       |
| $I_{DM}$                          | Pulsed Drain Current ①⑤                                 | 72           |       |
| $P_D$ @ $T_A = 25^\circ\text{C}$  | Maximum Power Dissipation                               | 3.8          | W     |
| $P_D$ @ $T_C = 25^\circ\text{C}$  | Maximum Power Dissipation                               | 45           | W     |
|                                   | Linear Derating Factor                                  | 0.30         | W/°C  |
| $V_{GS}$                          | Gate-to-Source Voltage                                  | ± 16         | V     |
| $E_{AS}$                          | Single Pulse Avalanche Energy ②⑤                        | 68           | mJ    |
| $I_{AR}$                          | Avalanche Current ①                                     | 11           | A     |
| $E_{AR}$                          | Repetitive Avalanche Energy ①                           | 4.5          | mJ    |
| $dv/dt$                           | Peak Diode Recovery ③⑤                                  | 5.0          | V/ns  |
| $T_J$                             | Operating Junction and                                  | -55 to + 175 | °C    |
| $T_{STG}$                         | Storage Temperature Range                               |              |       |
|                                   | Soldering Temperature, for 10 seconds (1.6mm from case) | 300          |       |

### Thermal Resistance

|                 | Parameter   | Typ. | Max. | Units |
|-----------------|---|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                                  | —    | 3.3  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mounted, steady-state)** | —    | 40   |       |

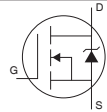
HEXFET® is a registered trademark of International Rectifier.

\*Qualification standards can be found at <http://www.irf.com/>

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

|                                 | Parameter                            | Min. | Typ.  | Max.  | Units               | Conditions   |
|---------------------------------|--------------------------------------|------|-------|-------|---------------------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 55   | —     | —     | V                   | $V_{GS} = 0V, I_D = 250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.061 | —     | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1mA$ ⑤         |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 0.060 | $\Omega$            | $V_{GS} = 10V, I_D = 11A$ ④                          |
|                                 |                                      | —    | —     | 0.075 |                     | $V_{GS} = 5.0V, I_D = 11A$ ④                         |
|                                 |                                      | —    | —     | 0.105 |                     | $V_{GS} = 4.0V, I_D = 9.0A$ ④                        |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 1.0  | —     | 2.0   | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                    |
| $g_{fs}$                        | Forward Transconductance             | 8.3  | —     | —     | S                   | $V_{DS} = 25V, I_D = 11A$ ⑤                          |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 25    | $\mu A$             | $V_{DS} = 55V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —     | 250   |                     | $V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 100   | nA                  | $V_{GS} = 16V$                                       |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -100  |                     | $V_{GS} = -16V$                                      |
| $Q_g$                           | Total Gate Charge                    | —    | —     | 15    | nC                  | $I_D = 11A$  |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —     | 3.7   |                     | $V_{DS} = 44V$                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —     | 8.5   |                     | $V_{GS} = 5.0V$ , See Fig. 6 and 13 ④⑤               |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 7.1   | —     | ns                  | $V_{DD} = 28V$                                       |
| $t_r$                           | Rise Time                            | —    | 74    | —     |                     | $I_D = 11A$  |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 20    | —     |                     | $R_G = 12\Omega, V_{GS} = 5.0V$                      |
| $t_f$                           | Fall Time                            | —    | 29    | —     |                     | $R_D = 2.4\Omega$ , See Fig. 10 ④⑤                   |
| $L_S$                           | Internal Source Inductance           | —    | 7.5   | —     | nH                  | Between lead, and center of die contact              |
| $C_{iss}$                       | Input Capacitance                    | —    | 480   | —     | pF                  | $V_{GS} = 0V$  |
| $C_{oss}$                       | Output Capacitance                   | —    | 130   | —     |                     | $V_{DS} = 25V$                                       |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 61    | —     |                     | $f = 1.0MHz$ , See Fig. 5⑤                           |

**Source-Drain Ratings and Characteristics**

|          | Parameter                              | Min.  | Typ. | Max. | Units | Conditions   |
|----------|--|---|------|------|-------|--|
| $I_S$    | Continuous Source Current (Body Diode) | —   | —    | 18   | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —   | —    | 72   |       |  |
| $V_{SD}$ | Diode Forward Voltage                  | —   | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 11A, V_{GS} = 0V$ ④   |
| $t_{rr}$ | Reverse Recovery Time                  | —   | 60   | 90   | ns    | $T_J = 25^\circ\text{C}, I_F = 11A$  |
| $Q_{rr}$ | Reverse Recovery Charge                | —   | 130  | 200  | nC    | $di/dt = 100A/\mu s$ ④⑤  |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |  |

**Notes**

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

②  $V_{DD} = 25V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 790\mu H$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 11A$ . (See Figure 12)

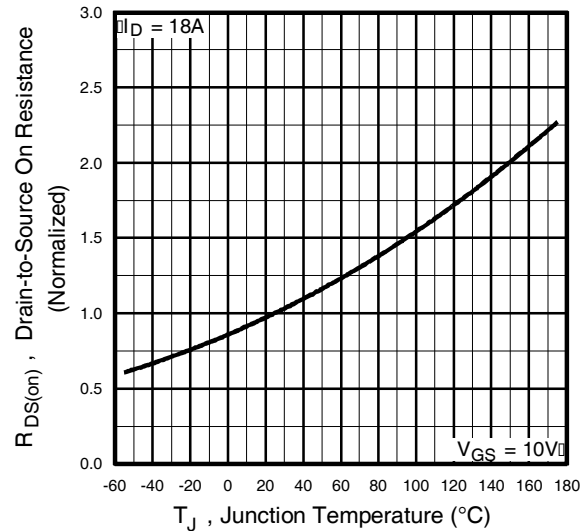
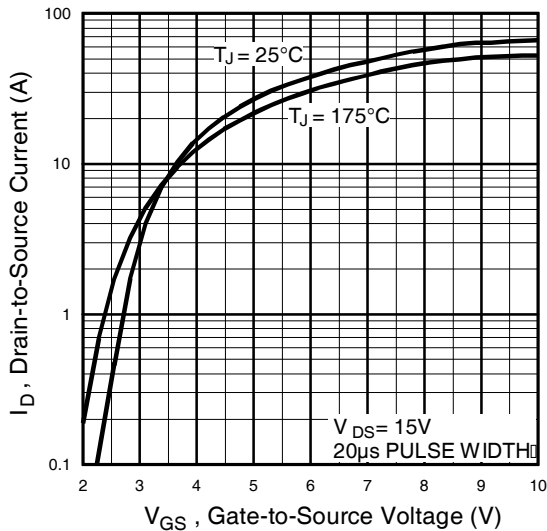
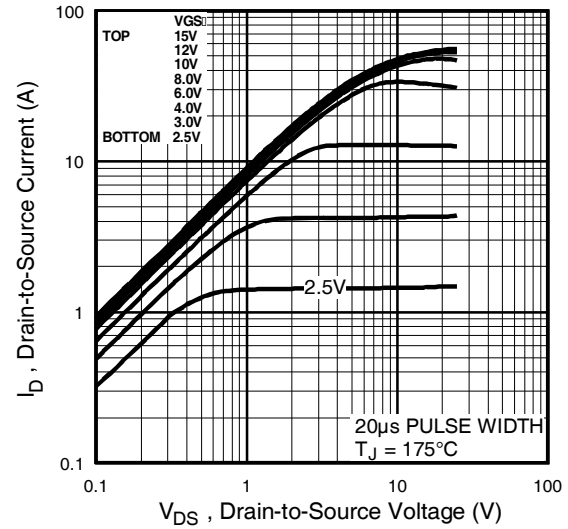
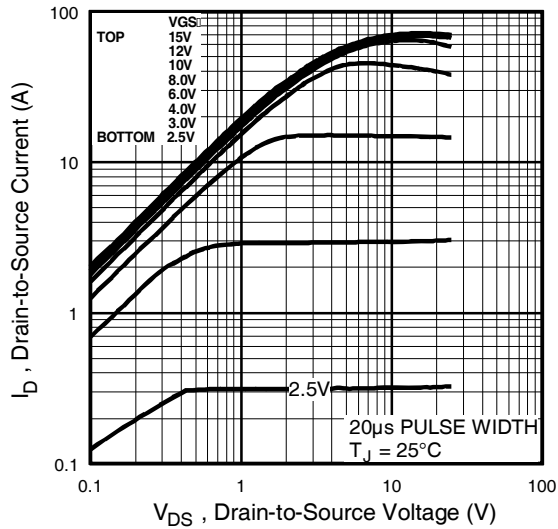
③  $I_{SD} \leq 11A$ ,  $di/dt \leq 290A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ\text{C}$

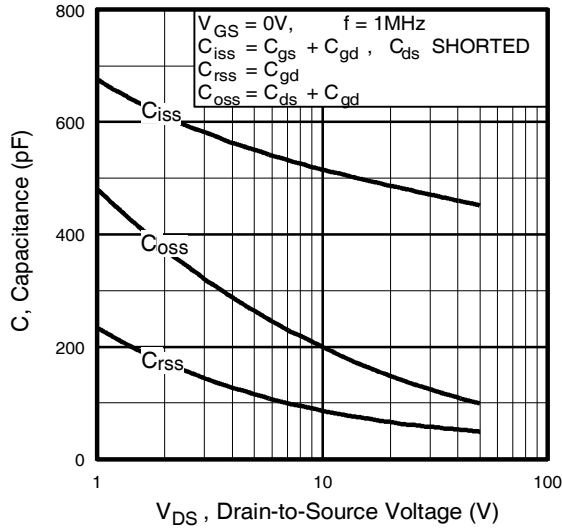
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .

⑤ Uses IRLZ24N data and test conditions.

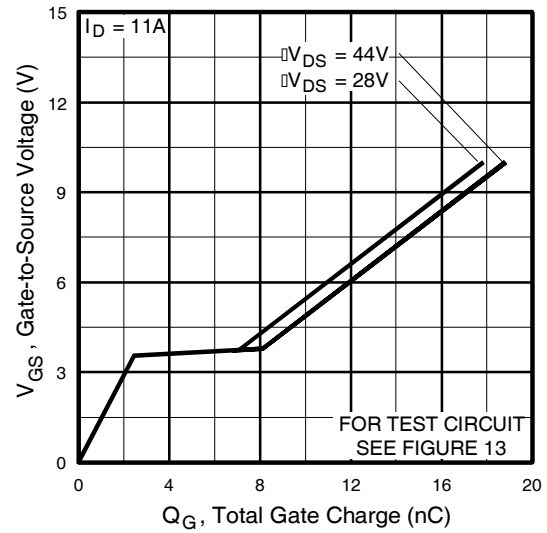
\*\* When mounted on 1" square PCB ( FR-4 or G-10 Material ).

For recommended footprint and soldering techniques refer to application note #AN-994.

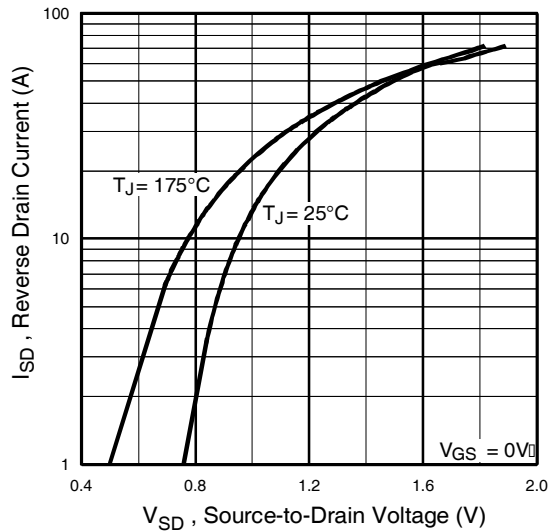




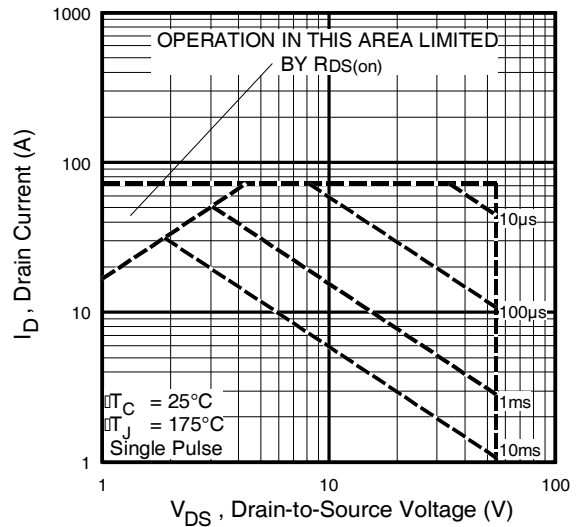
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



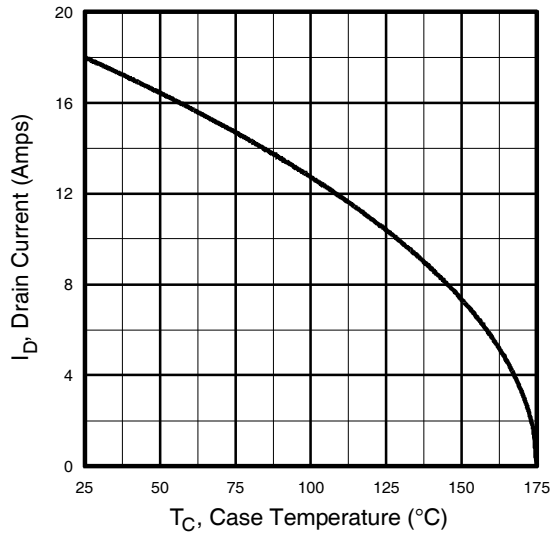
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



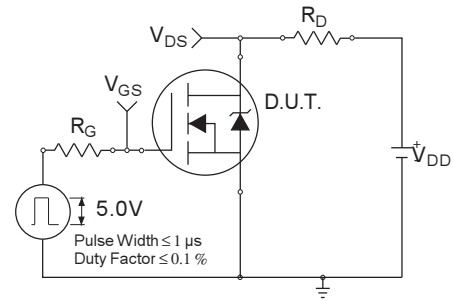
**Fig 7.** Typical Source-Drain Diode



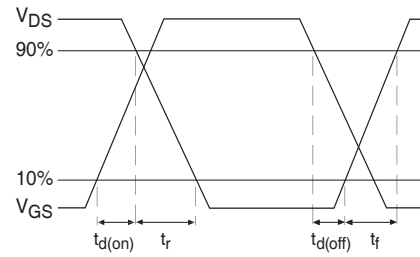
**Fig 8.** Maximum Safe Operating Area



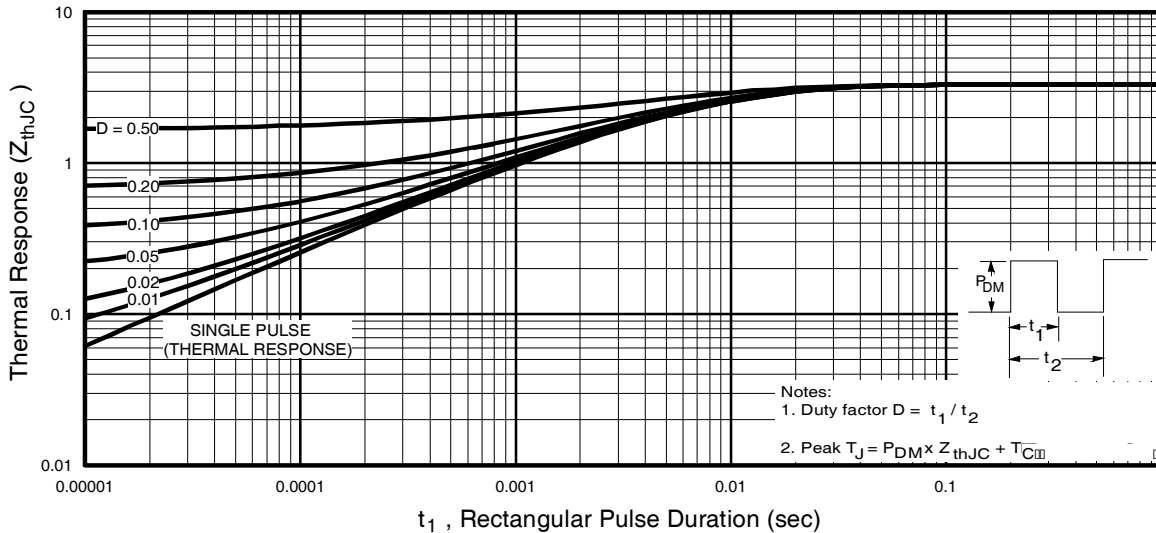
**Fig 9.** Maximum Drain Current Vs. Case Temperature



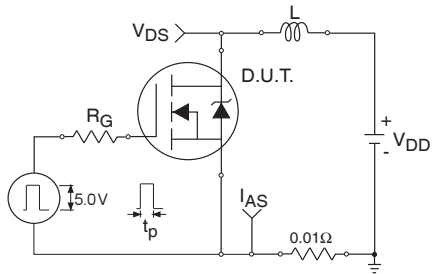
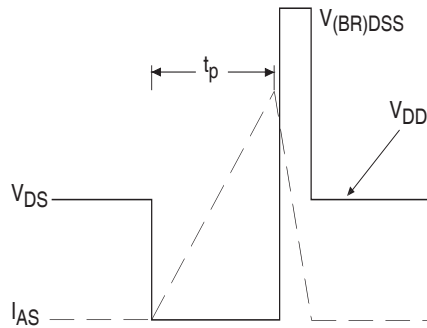
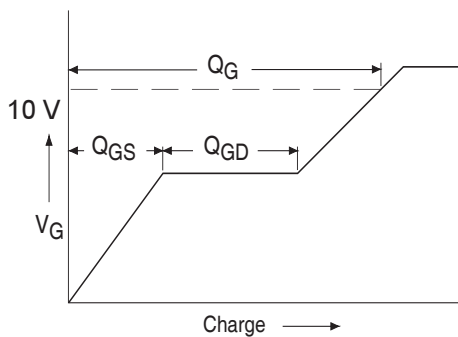
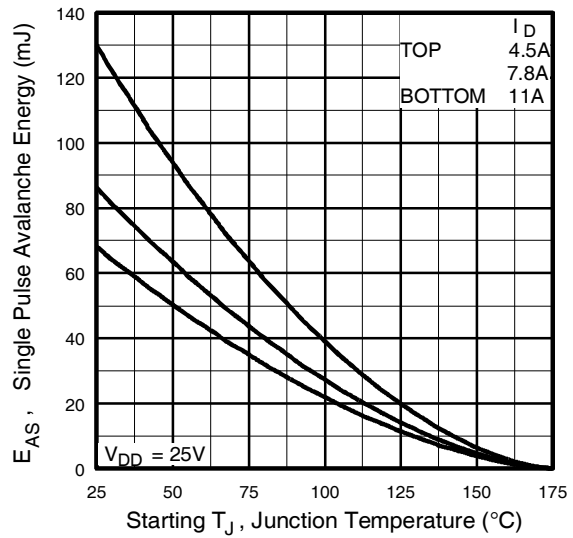
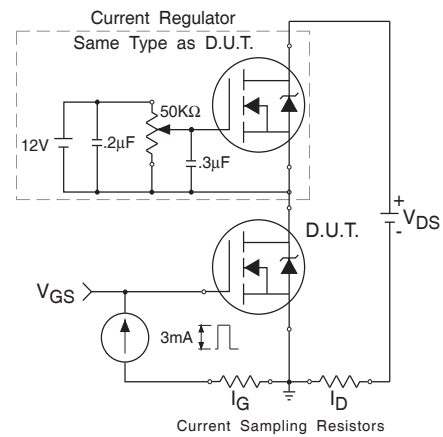
**Fig 10a.** Switching Time Test Circuit



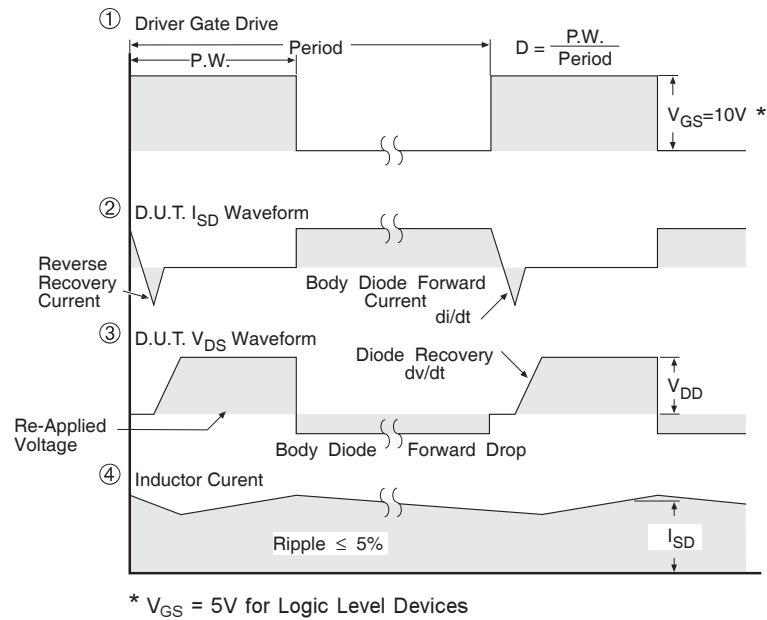
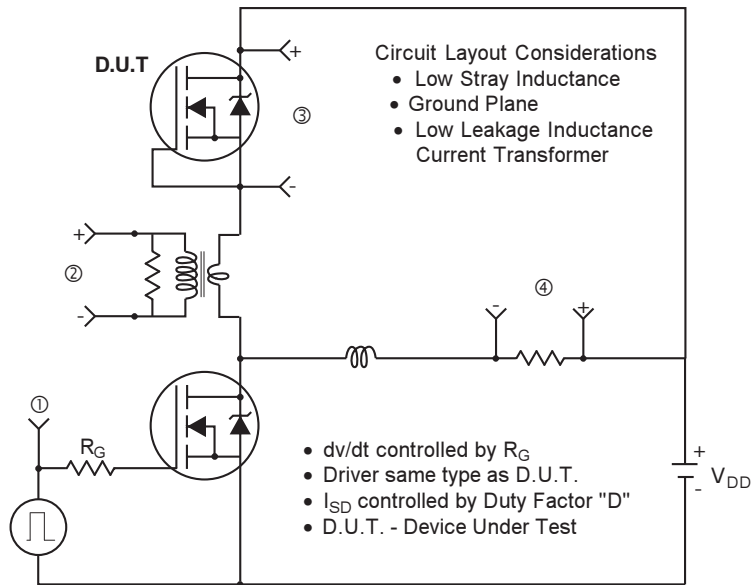
**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case


**Fig 12a. Unclamped Inductive Test Circuit**

**Fig 12b. Unclamped Inductive Waveforms**

**Fig 13a. Basic Gate Charge Waveform**

**Fig 12c. Maximum Avalanche Energy Vs. Drain Current**

**Fig 13b. Gate Charge Test Circuit**

### Peak Diode Recovery dv/dt Test Circuit



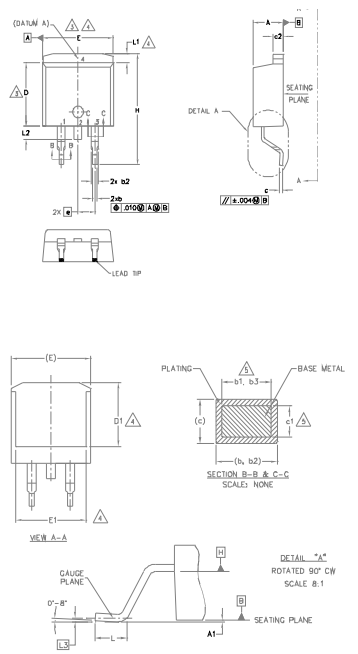
**Fig 14. For N-Channel HEXFETS**



## AUIRLZ24NS/AUIRLZ24NL

### D<sup>2</sup>Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 |       |
| A1     | 0.00        | 0.254 | .000     | .010 |       |
| b      | 0.51        | 0.99  | .020     | .039 | 5     |
| b1     | 0.51        | 0.89  | .020     | .035 |       |
| b2     | 1.14        | 1.78  | .045     | .070 | 5     |
| b3     | 1.14        | 1.73  | .045     | .068 |       |
| c      | 0.38        | 0.74  | .015     | .029 | 5     |
| c1     | 0.38        | 0.58  | .015     | .023 |       |
| c2     | 1.14        | 1.65  | .045     | .065 | 3     |
| D      | 8.38        | 9.65  | .330     | .380 |       |
| D1     | 6.86        | —     | .270     | —    | 4     |
| E      | 9.65        | 10.67 | .380     | .420 |       |
| E1     | 6.22        | —     | .245     | —    | 4     |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| H      | 14.61       | 15.88 | .575     | .625 | 4     |
| L      | 1.78        | 2.79  | .070     | .110 |       |
| L1     | —           | 1.68  | —        | .066 |       |
| L2     | —           | 1.78  | —        | .070 |       |
| L3     | 0.25 BSC    |       | .010 BSC |      |       |

#### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1, b3 AND c1 APPLY TO BASE METAL ONLY.
6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
7. CONTROLLING DIMENSION: INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

#### LEAD ASSIGNMENTS

##### DIODES

- 1.— ANODE (TWO DIE) / OPEN (ONE DIE)
- 2.— CATHODE
- 3.— ANODE

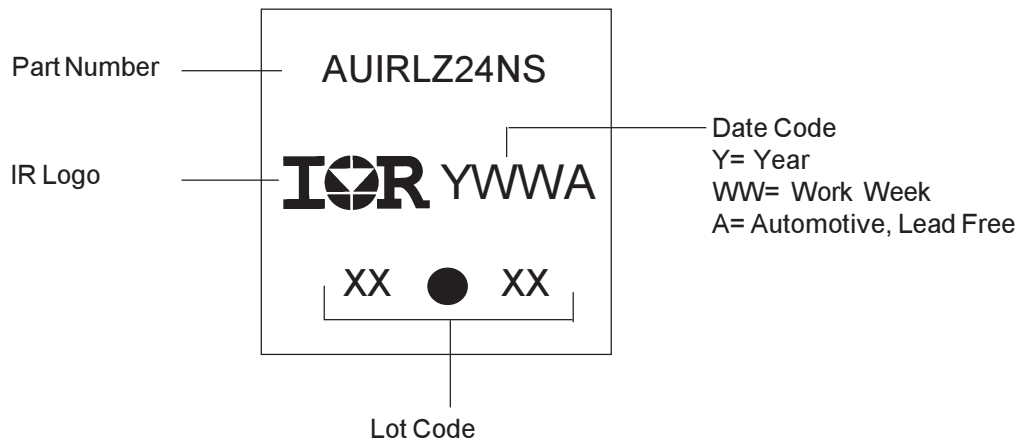
##### HEXFET

- 1.— GATE
- 2, 4.— DRAIN
- 3.— SOURCE

##### IGBTs, CoPACK

- 1.— GATE
- 2, 4.— COLLECTOR
- 3.— EMITTER

### D<sup>2</sup>Pak Part Marking Information



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

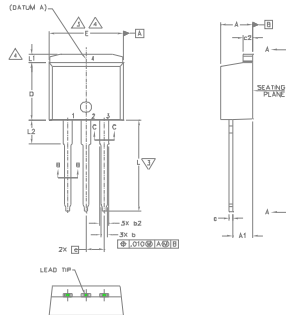




## AUIRLZ24NS/AUIRLZ24NL

### TO-262 Package Outline

Dimensions are shown in millimeters (inches)



| SYMBOL | DIMENSIONS  |       |          |      | NOTES   |
|--------|-------------|-------|----------|------|---|
|        | MILLIMETERS |       | INCHES   |      |   |
|        |             |       |          |      |   |
|        | MIN.        | MAX.  | MIN.     | MAX. |   |
| A      | 4.06        | 4.83  | .160     | .190 | 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994  |
| A1     | 2.03        | 3.02  | .080     | .119 |   |
| b      | 0.51        | 0.99  | .020     | .039 | 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].  |
| b1     | 0.51        | 0.89  | .020     | .035 |   |
| b2     | 1.14        | 1.78  | .045     | .070 | 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY. |
| b3     | 1.14        | 1.73  | .045     | .068 |   |
| c      | 0.38        | 0.74  | .015     | .029 | 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.  |
| c1     | 0.38        | 0.58  | .015     | .023 |   |
| c2     | 1.14        | 1.65  | .045     | .065 | 5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.  |
| D      | 8.38        | 9.65  | .330     | .380 |   |
| D1     | 6.86        | —     | .270     | —    | 6. CONTROLLING DIMENSION: INCH.   |
| E      | 9.65        | 10.67 | .380     | .420 |   |
| E1     | 6.22        | —     | .245     | —    |   |
| e      | 2.54 BSC    |       | .100 BSC |      |   |
| L      | 13.46       | 14.10 | .530     | .555 |   |
| L1     | — 1.65      |       | — .065   |      |   |
| L2     | 3.56        | 3.71  | .140     | .146 |   |

#### NOTES:

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3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. CONTROLLING DIMENSION: INCH.
7. OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

#### LEAD ASSIGNMENTS

##### IGBTs, CoPACK

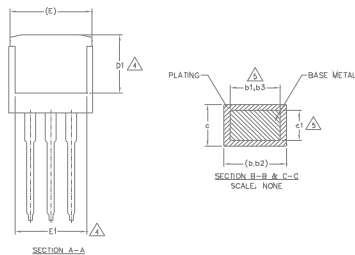
- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

##### HEXFET

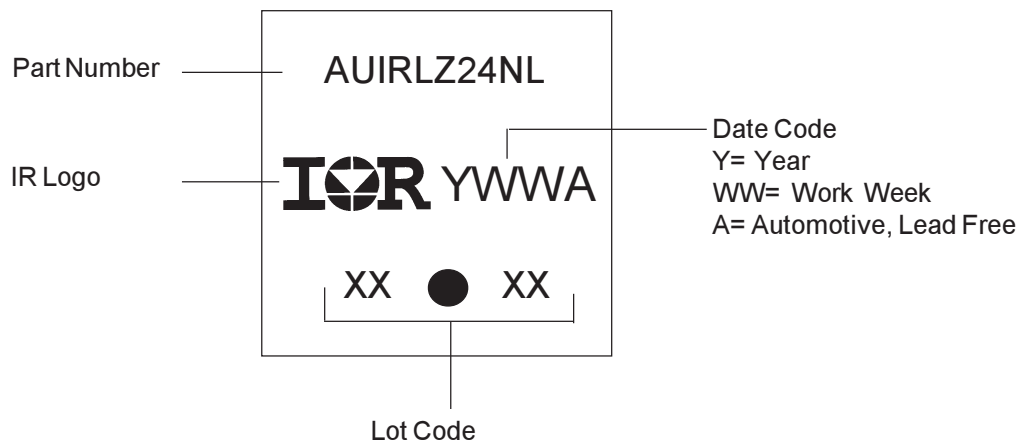
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

##### DIODES

- 1.- ANODE (TWO DIE) / OPEN (ONE DIE)
- 2, 4.- CATHODE
- 3.- ANODE



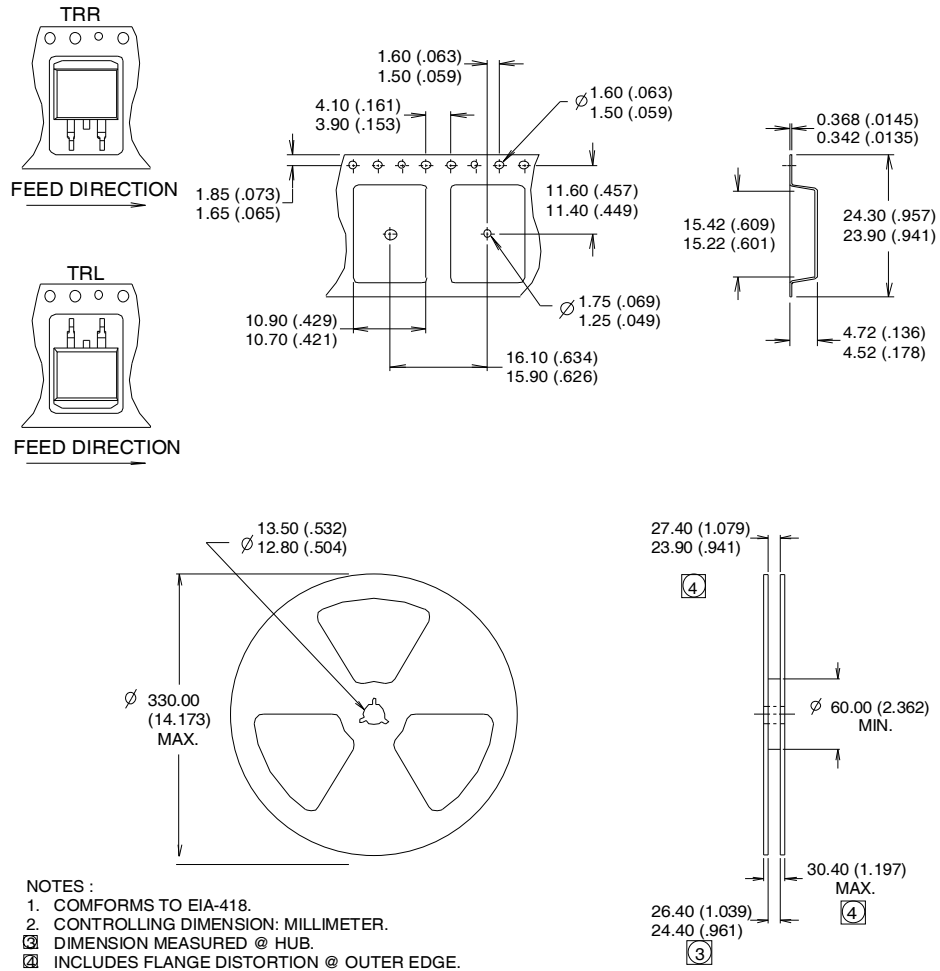
### TO-262 Part Marking Information



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Qualification Information<sup>†</sup>**

|                            |                      |   |      |
|----------------------------|----------------------|---|------|
| Qualification Level        |                      | Automotive<br>(per AEC-Q101)  |      |
|                            |                      | Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. |      |
| Moisture Sensitivity Level |                      | 3L-D2 PAK   | MSL1 |
|                            |                      | 3L-TO-262   |      |
| ESD                        | Machine Model        | Class M2(+/- 150V ) <sup>††</sup><br>(per AEC-Q101-002)   |      |
|                            | Human Body Model     | Class H1A(+/- 500V ) <sup>††</sup><br>(per AEC-Q101-001)  |      |
|                            | Charged Device Model | Class C5(+/- 2000V ) <sup>††</sup><br>(per AEC-Q101-005)  |      |
| RoHS Compliant             |                      | Yes   |      |

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/>

<sup>††</sup> Highest passing voltage

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